



DST3946DPJ

COMPLEMENTARY NPN/PNP SURFACE MOUNT TRANSISTOR

Features

- Epitaxial Planar Die Construction
- Ideally Suited for Automated Assembly Processes
- Lead, Halogen and Antimony Free, RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Ultra Small Package

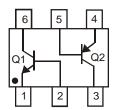
Mechanical Data

- Case: SOT-963
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.0027 grams (approximate)

SOT-963



Top View



Device Schematic

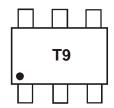
Ordering Information (Note 5)

| Device | Packaging | Shipping |
|--------------|-----------|--------------------|
| DST3946DPJ-7 | SOT-963 | 10.000/Tape & Reel |

Notes:

- 1. No purposefully added lead. Halogen and Antimony Free.
- 2. Diodes Inc's "Green" Policy can be found on our website at http://www.diodes.com

Marking Information



T9 = Product Type Marking Code



Maximum Ratings - NPN (Q1) @T_A = 25°C unless otherwise specified

| Characteristic | Symbol | Value | Unit |
|--------------------------------|------------------|-------|------|
| Collector-Base Voltage | V_{CBO} | 60 | V |
| Collector-Emitter Voltage | V _{CEO} | 40 | V |
| Emitter-Base Voltage | V_{EBO} | 6.0 | V |
| Collector Current – Continuous | Ic | 200 | mA |

Maximum Ratings - PNP (Q2) @T_A = 25°C unless otherwise specified

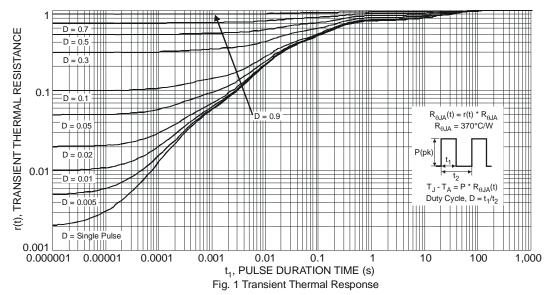
| Characteristic | Symbol | Value | Unit |
|--------------------------------|------------------|-------|------|
| Collector-Base Voltage | V_{CBO} | -40 | V |
| Collector-Emitter Voltage | V_{CEO} | -40 | V |
| Emitter-Base Voltage | V _{EBO} | -5.0 | V |
| Collector Current - Continuous | Ic | -200 | mA |

Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--|-----------------------------------|-------------|------|
| Power Dissipation (Note 3) | P_{D} | 300 | mW |
| Thermal Resistance, Junction to Ambient (Note 3) | $R_{	hetaJA}$ | 417 | °C/W |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |

Notes: 3. Device mounted on FR-4 PCB with minimum recommended pad layout.





1,000

| Single Pulse | R_{0JA}(t) = r(t) * R_{0JA} | R_{0JA} = 370°C/W | T_J · T_A = P * R_{0JA}(t) | Duty Cycle, D = t₁/t₂ | Duty Cycle, D

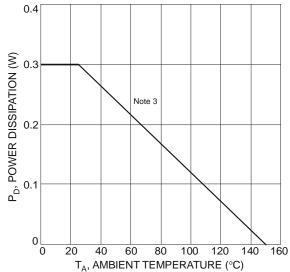


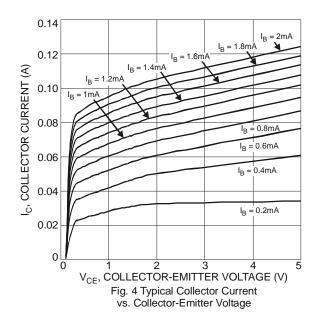
Fig. 3 Power Dissipation vs. Ambient Temperature

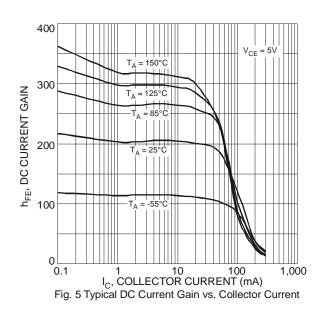


Electrical Characteristics - NPN (Q1) @T_A = 25°C unless otherwise specified

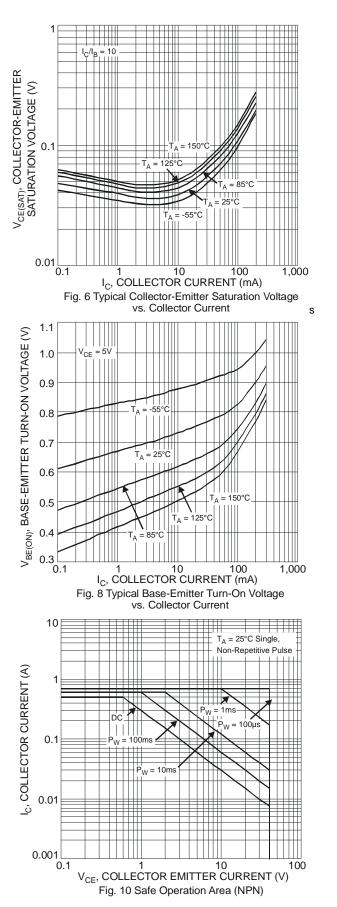
| Characteristic | Symbol | Min | Max | Unit | Test Condition |
|--|----------------------|------|------|--------------------|--|
| OFF CHARACTERISTICS (Note 4) | | | | | |
| Collector-Base Breakdown Voltage | V _{(BR)CBO} | 60 | _ | V | $I_C = 10\mu A, I_E = 0$ |
| Collector-Emitter Breakdown Voltage (Note 4) | V _{(BR)CEO} | 40 | _ | V | $I_C = 1.0 \text{mA}, I_B = 0$ |
| Emitter-Base Breakdown Voltage | V _{(BR)EBO} | 6.0 | _ | V | $I_E = 10 \mu A, I_C = 0$ |
| Collector Cutoff Current | I _{CEX} | | 50 | nA | $V_{CE} = 30V, V_{EB(OFF)} = 3.0V$ |
| Base Cutoff Current | I_{BL} | | 50 | nA | $V_{CE} = 30V, V_{EB(OFF)} = 3.0V$ |
| ON CHARACTERISTICS (Note 4) | | | | | |
| | | 40 | _ | | $I_C = 100 \mu A, V_{CE} = 1.0 V$ |
| | | 70 | _ | | $I_C = 1.0 \text{mA}, V_{CE} = 1.0 \text{V}$ |
| DC Current Gain | h _{FE} | 100 | 300 | | $I_C = 10 \text{mA}, V_{CE} = 1.0 \text{V}$ |
| | | 60 | _ | | $I_C = 50 \text{mA}, V_{CE} = 1.0 \text{V}$ |
| | | 30 | _ | | $I_C = 100 \text{mA}, V_{CE} = 1.0 \text{V}$ |
| Collector-Emitter Saturation Voltage | V | | 0.20 | V | $I_C = 10 \text{mA}, I_B = 1.0 \text{mA}$ |
| Collector-Emitter Saturation Voltage | V _{CE(SAT)} | _ | 0.30 | V | $I_C = 50 \text{mA}, I_B = 5.0 \text{mA}$ |
| Base-Emitter Saturation Voltage | V _{BE(SAT)} | 0.65 | 0.85 | V | $I_C = 10mA, I_B = 1.0mA$ |
| · · | | _ | 0.95 | ٧ | $I_C = 50 \text{mA}, I_B = 5.0 \text{mA}$ |
| SMALL SIGNAL CHARACTERISTICS | | | | | |
| Output Capacitance | C_{obo} | _ | 4.0 | pF | $V_{CB} = 5.0V$, $f = 1.0MHz$, $I_E = 0$ |
| Input Capacitance | Cibo | _ | 8.5 | pF | $V_{EB} = 0.5V$, $f = 1.0MHz$, $I_{C} = 0$ |
| Input Impedance | h _{ie} | 1.0 | 10 | kΩ | |
| Voltage Feedback Ratio | h _{re} | 0.5 | 8.0 | x 10 ⁻⁴ | $V_{CE} = 10V, I_{C} = 1.0mA,$ |
| Small Signal Current Gain | h _{fe} | 100 | 400 | _ | f = 1.0kHz |
| Output Admittance | h _{oe} | 1.0 | 40 | μS | |
| Current Gain-Bandwidth Product | f⊤ | 300 | _ | MHz | $V_{CE} = 20V, I_{C} = 10mA,$ f = 100MHz |
| SWITCHING CHARACTERISTICS | | | | | |
| Delay Time | t _d | _ | 35 | ns | $V_{CC} = 3.0V, I_C = 10mA,$ |
| Rise Time | t _r | _ | 35 | ns | $V_{BE(off)} = -0.5V, I_{B1} = 1.0mA$ |
| Storage Time | ts | | 200 | ns | $V_{CC} = 3.0V, I_C = 10mA,$ |
| Fall Time | t _f | | 50 | ns | $I_{B1} = I_{B2} = 1.0 \text{mA}$ |

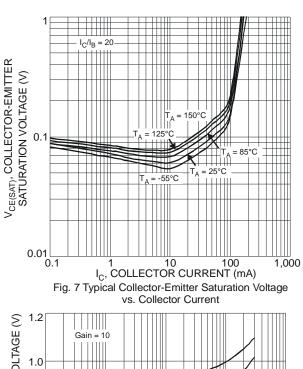
Notes: 4. Short duration pulse test used to minimize self-heating effect.

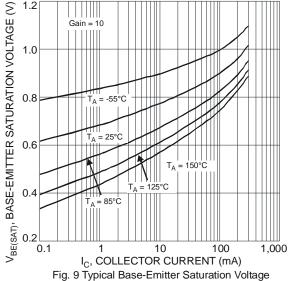










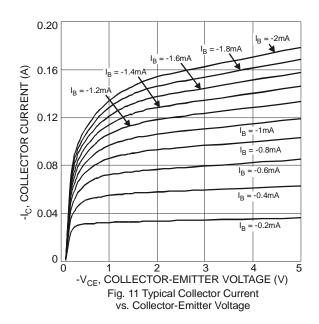


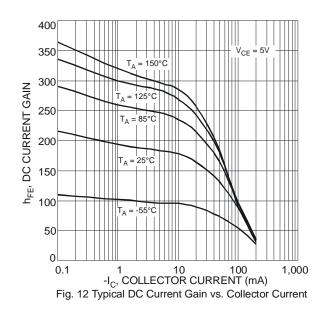


Electrical Characteristics - PNP (Q2) @TA = 25°C unless otherwise specified

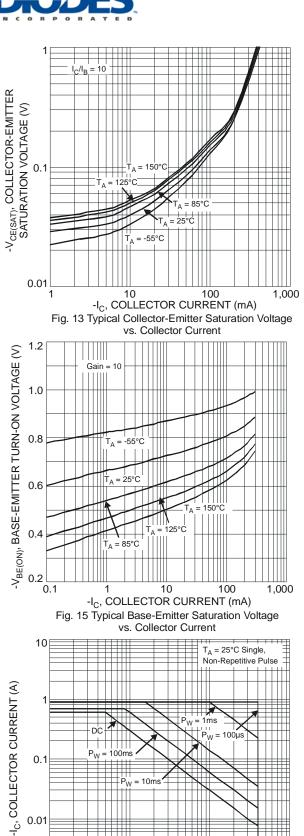
| Characteristic | Symbol | Min | Max | Unit | Test Condition | |
|--|----------------------|-----------------|----------------|--------------------|--|--|
| OFF CHARACTERISTICS | | | | | | |
| Collector-Base Breakdown Voltage | V _{(BR)CBO} | -40 | _ | V | $I_C = -10\mu A, I_E = 0$ | |
| Collector-Emitter Breakdown Voltage (Note 4) | V _{(BR)CEO} | -40 | _ | V | $I_C = -1.0 \text{mA}, I_B = 0$ | |
| Emitter-Base Breakdown Voltage | $V_{(BR)EBO}$ | -5.0 | _ | V | $I_E = -10\mu A, I_C = 0$ | |
| Collector Cutoff Current | I _{CEX} | | -50 | nA | $V_{CE} = -30V, V_{EB(OFF)} = -3.0V$ | |
| Collector Guton Gurrent | I _{CBO} | | -50 | nA | $V_{CE} = -30V, I_{E} = 0$ | |
| Base Cutoff Current | I_{BL} | _ | -50 | nA | $V_{CE} = -30V, V_{EB(OFF)} = -3.0V$ | |
| ON CHARACTERISTICS (Note 4) | | | | | | |
| | | 60 80 | _ | | $I_C = -1.00 \mu A$, $V_{CE} = -1.0 V$ $I_C = -1.0 mA$, $V_{CE} = -1.0 V$ | |
| DC Current Gain | h _{FE} | 100 60 30 | 300 — — | _ | I _C = -10mA, V _{CE} = -1.0V I _C = -50mA, V _{CE} = -1.0V I _C = -100mA, V _{CE} = -1.0V | |
| Collector-Emitter Saturation Voltage | V _{CE(SAT)} | | -0.25 -0.40 | V | I _C = -10mA, I _B = -1.0mA I _C = -50mA, I _B = -5.0mA | |
| Base-Emitter Saturation Voltage | V _{BE(SAT)} | -0.65 — | -0.85 -0.95 | V | $I_C = -10 \text{mA}, I_B = -1.0 \text{mA}$ $I_C = -50 \text{mA}, I_B = -5.0 \text{mA}$ | |
| SMALL SIGNAL CHARACTERISTICS | | | | | | |
| Output Capacitance | C_obo | | 4.5 | pF | $V_{CB} = -5.0V$, $f = 1.0MHz$, $I_E = 0$ | |
| Input Capacitance | C_{ibo} | _ | 10 | pF | $V_{EB} = -0.5V$, $f = 1.0MHz$, $I_{C} = 0$ | |
| Input Impedance | h _{ie} | 2.0 | 12 | kΩ | | |
| Voltage Feedback Ratio | h _{re} | 0.1 | 10 | x 10 ⁻⁴ | $V_{CE} = 10V, I_{C} = 1.0mA,$ | |
| Small Signal Current Gain | h _{fe} | 100 | 400 | _ | f = 1.0kHz | |
| Output Admittance | h _{oe} | 3.0 | 60 | μS | 1 | |
| Current Gain-Bandwidth Product | f _T | 300 | _ | MHz | $V_{CE} = -20V, I_{C} = -10mA,$ f = 100MHz | |
| SWITCHING CHARACTERISTICS | | | | | | |
| Delay Time | t _d | _ | 35 | ns | $V_{CC} = -3.0V, I_{C} = -10mA,$ | |
| Rise Time | t _r | | 35 | ns | $V_{BE(off)} = 0.5V, I_{B1} = -1.0mA$ | |
| Storage Time | ts | _ | 225 | ns | $V_{CC} = -3.0V, I_{C} = -10mA,$ | |
| Fall Time | t _f | | 75 | ns | $I_{B1} = I_{B2} = -1.0 \text{mA}$ | |

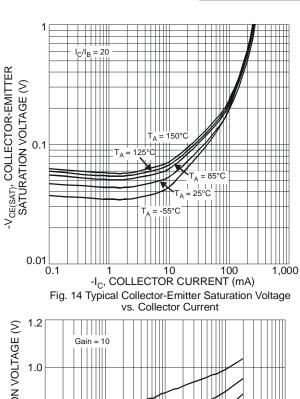
Notes: 4. Short duration pulse test used to minimize self-heating effect.

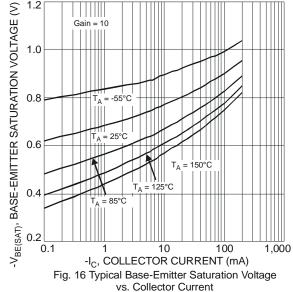












0.1

0.001 0.1 100ms

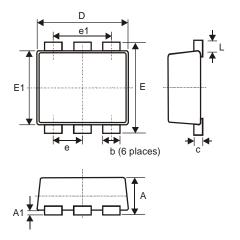
P_W = 10ms

10

-V_{CE}, COLLECTOR EMITTER CURRENT (V) Fig. 17 Safe Operation Area (PNP)

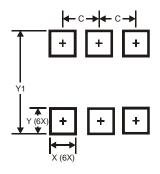


Package Outline Dimensions



| | SOT-963 | | | | | |
|-------------------|----------------------|-------|-------|--|--|--|
| Dim | Min | Max | Тур | | | |
| Α | 0.40 | 0.50 | 0.45 | | | |
| A1 | 0 | 0.05 | - | | | |
| С | 0.120 | 0.180 | 0.150 | | | |
| D | 0.95 | 1.05 | 1.00 | | | |
| Е | 0.95 | 1.05 | 1.00 | | | |
| E1 | 0.75 | 0.85 | 0.80 | | | |
| L | 0.05 | 0.15 | 0.10 | | | |
| b | 0.10 | 0.20 | 0.15 | | | |
| e 0.35 Typ | | | | | | |
| e1 | e1 0.70 Typ | | | | | |
| All | All Dimensions in mm | | | | | |

Suggested Pad Layout



| Dimensions | Value (in mm) | | |
|------------|---------------|--|--|
| С | 0.350 | | |
| Х | 0.200 | | |
| Y | 0.200 | | |
| Y1 | 1.100 | | |



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